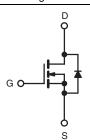


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	200			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	0.80		
Q _g (Max.) (nC)	14			
Q _{gs} (nC)	3.0			
Q _{gd} (nC)	7.9			
Configuration	Single			





N-Channel MOSFET

FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- · For Automatic Insertion
- End Stackable
- · Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 W.

ORDERING INFORMATION		
Package	HEXDIP	
Lead (Pb)-free	IRFD220PbF	
Lead (PD)-liee	SiHFD220-E3	
SnPb	IRFD220	
	SiHFD220	

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	200	V	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	V_{GS} at 10 V $T_C = 2$	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	I _D	0.80	А	
	V _{GS} at 10 V	T _C = 100 °C		0.50		
Pulsed Drain Current ^a			I _{DM}	6.4		
Linear Derating Factor				0.0083	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	260	mJ	
Repetitive Avalanche Current ^a			I _{AR}	5.2	А	
Repetitive Avalanche Energy ^a			E _{AR}	0.10	mJ	
Maximum Power Dissipation	T _C = 25 °C		P _D	1.0	W	
Peak Diode Recovery dV/dt ^c			dV/dt	5.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	- °C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 152 mH, R_G = 25 Ω , I_{AS} = 1.6 A (see fig. 12).
- c. $I_{SD} \le 5.2$ A, $dI/dt \le 95$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFD220, SiHFD220

Vishay Siliconix



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R_{thJA}	=	120	°C/W	

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		200	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	0.29	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_D = 250 \mu A$		-	4.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA
Zone Cote Voltage Duein Comment		V _{DS} =	= 200 V, V _{GS} = 0 V	-	-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 160 V	V _{DS} = 160 V, V _{GS} = 0 V, T _J = 125 °C		-	250	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 0.48 A ^b	-	-	0.80	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 50 V, I _D = 0.48 A ^b		0.60	-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5		-	260	-	pF
Output Capacitance	C _{oss}			-	100	-	
Reverse Transfer Capacitance	C _{rss}			-	30	-	
Total Gate Charge	Qg			-	-	14	
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 \text{ V}$ $I_D = 4.8 \text{ A}, V_{DS} = 160 \text{ V},$ see fig.6 and 13 ^b		-	-	3.0	nC
Gate-Drain Charge	Q _{gd}	7	ooo ng.o ana ro	-	-	7.9	
Turn-On Delay Time	t _{d(on)}	V_{DD} = 100 V, I_{D} = 4.8 A, R_{G} = 18 Ω , R_{D} = 19 Ω , see fig. 10 ^b		-	7.2	-	- ns
Rise Time	t _r			-	22	-	
Turn-Off Delay Time	t _{d(off)}			-	19	-	
Fall Time	t _f			-	13	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.0	-	- nH
Internal Source Inductance	L _S			-	6.0	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	0.80	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	6.4	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, \ I_S = 0.80 \text{A}, \ V_{GS} = 0 \text{V}^b$		-	-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 4.8 A, dl/dt = 100 A/μs ^b		-	150	300	ns
Body Diode Reverse Recovery Charge	Q_{rr}			_	0.91	1.8	μС
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time is negligible (turn	-on is don	ninated by	y L _S and I	L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%$





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

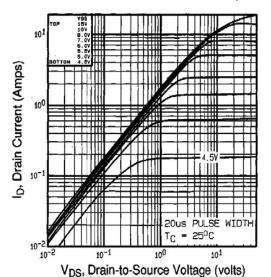


Fig. 1 - Typical Output Characteristics, $T_C = 25\ ^{\circ}C$

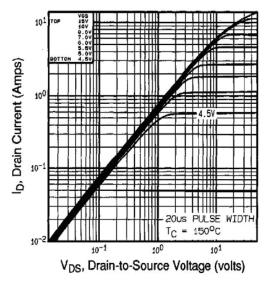


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

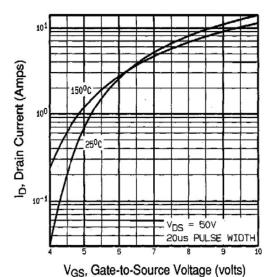


Fig. 3 - Typical Transfer Characteristics

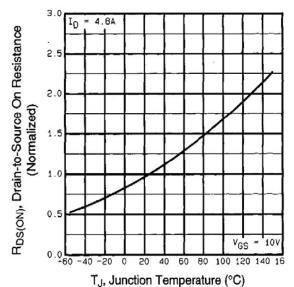


Fig. 4 - Normalized On-Resistance vs. Temperature

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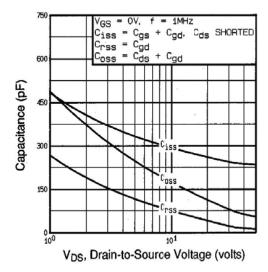


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

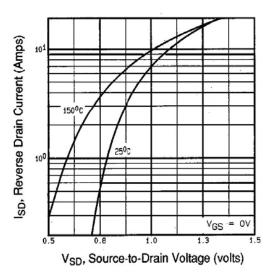


Fig. 7 - Typical Source-Drain Diode Forward Voltage

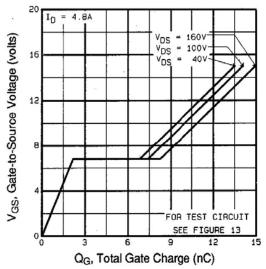


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

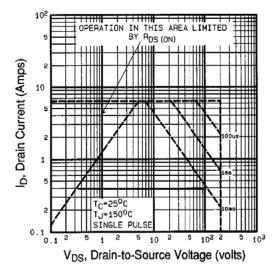


Fig. 8 - Maximum Safe Operating Area





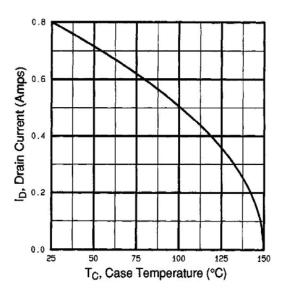


Fig. 9 - Maximum Drain Current vs. Case Temperature

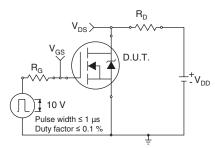


Fig. 10a - Switching Time Test Circuit

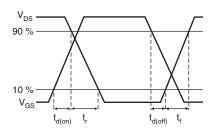


Fig. 10b - Switching Time Waveforms

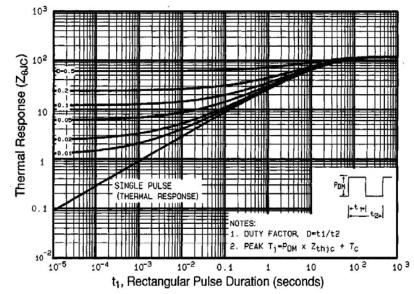


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

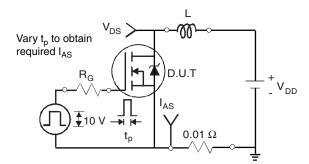


Fig. 12a - Unclamped Inductive Test Circuit

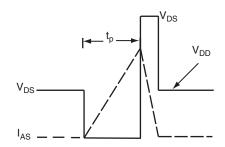


Fig. 12b - Unclamped Inductive Waveforms

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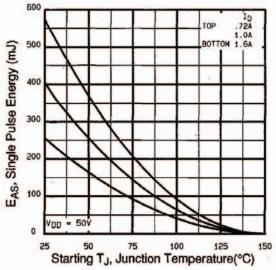


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

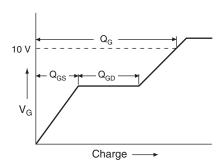


Fig. 13a - Basic Gate Charge Waveform

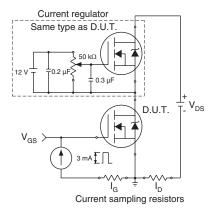
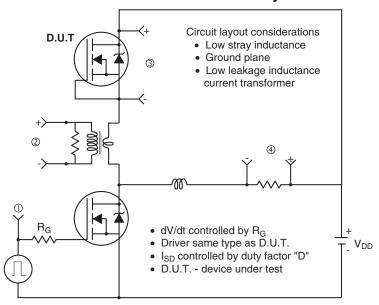
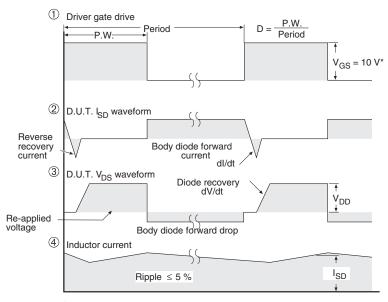


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





* $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel

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